

# N-channel silicon junction FETs

**J108; J109; J110**

## FEATURES

- High speed switching
- Interchangeability of drain and source connections
- Low  $R_{DS(on)}$  at zero gate voltage ( $<8\ \Omega$  for J108).

## APPLICATIONS

- Analog switches
- Choppers and commutators.

## DESCRIPTION

N-channel symmetrical silicon junction field-effect transistors in a TO-92 package.

### CAUTION

The device is supplied in an antistatic package. The gate-source input must be protected against static discharge during transport or handling.

## PINNING - TO-92

PIN	SYMBOL	DESCRIPTION
1	g	gate
2	s	source
3	d	drain

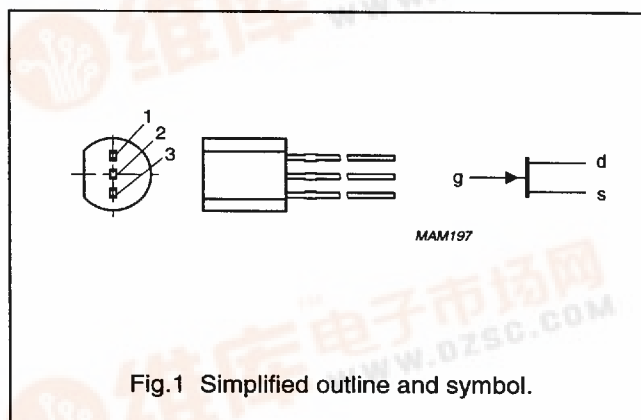


Fig.1 Simplified outline and symbol.

## QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{DS}$	drain-source voltage		—	$\pm 25$	V
$V_{GS(off)}$	gate-source cut-off voltage	$I_D = 1\ \mu A$ ; $V_{DS} = 5\ V$	—3	—10	V
	J108		—2	—6	V
	J109		—0.5	—4	V
	J110				V
$I_{DSS}$	drain current	$V_{GS} = 0$ ; $V_{DS} = 5\ V$	80	—	mA
	J108		40	—	mA
	J109		10	—	mA
	J110				mA
$P_{tot}$	total power dissipation	up to $T_{amb} = 50\ ^\circ C$	—	400	mW

[查询"J108AMC"供应商](#)  
**N-channel silicon junction FETs**
**J108; J109; J110****LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{DS}$	drain-source voltage		–	$\pm 25$	V
$V_{GSO}$	gate-source voltage	open drain	–	–25	V
$V_{GDO}$	gate-drain voltage	open source	–	–25	V
$I_G$	forward gate current (DC)		–	50	mA
$P_{tot}$	total power dissipation	up to $T_{amb} = 50\text{ }^{\circ}\text{C}$	–	400	mW
$T_{stg}$	storage temperature		–65	150	$^{\circ}\text{C}$
$T_j$	operating junction temperature		–	150	$^{\circ}\text{C}$

**THERMAL CHARACTERISTICS**

SYMBOL	PARAMETER	VALUE	UNIT
$R_{th\ j-a}$	thermal resistance from junction to ambient	250	K/W

**STATIC CHARACTERISTICS** $T_j = 25\text{ }^{\circ}\text{C}$ ; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)GSS}$	gate-source breakdown voltage	$I_G = -1\text{ }\mu\text{A}$ ; $V_{DS} = 0$	–	–	–25	V
$V_{GSoff}$	gate-source cut-off voltage	$I_D = 1\text{ }\mu\text{A}$ ; $V_{DS} = 5\text{ V}$				V
	J108		–3	–	–10	V
	J109		–2	–	–6	V
	J110		–0.5	–	–4	V
$I_{DSS}$	drain current	$V_{GS} = 0$ ; $V_{DS} = 15\text{ V}$				mA
	J108		80	–	–	mA
	J109		40	–	–	mA
	J110		10	–	–	mA
$I_{GSS}$	gate leakage current	$V_{GS} = -15\text{ V}$ ; $V_{DS} = 0$	–	–	–3	nA
$I_{DSX}$	drain-source cut-off current	$V_{GS} = -10\text{ V}$ ; $V_{DS} = 5\text{ V}$	–	–	3	nA
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = 0$ ; $V_{DS} = 100\text{ mV}$				$\Omega$
	J108		–	–	8	$\Omega$
	J109		–	–	12	$\Omega$
	J110		–	–	18	$\Omega$

查询"J108AMQ"供应商

N-channel silicon junction FETs

J108; J109; J110

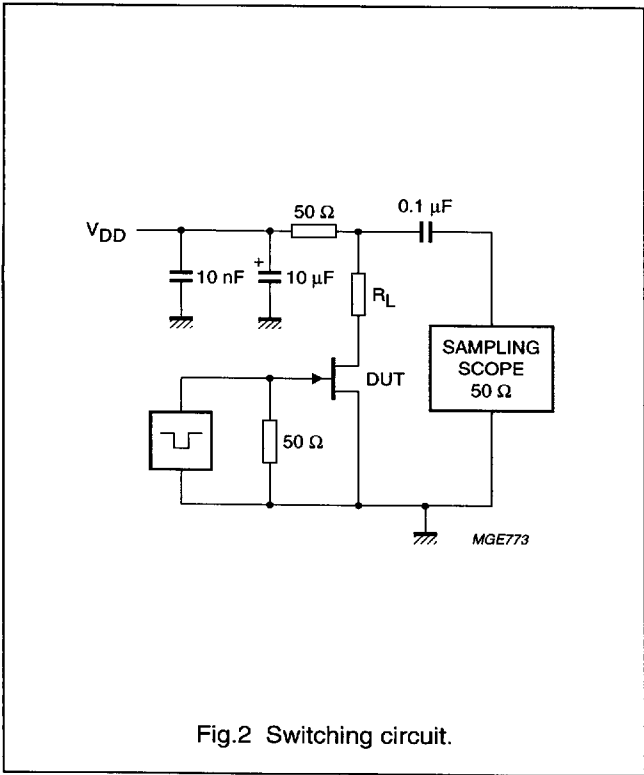
DYNAMIC CHARACTERISTICS

T<sub>J</sub> = 25 °C; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
C <sub>is</sub>	input capacitance	V <sub>DS</sub> = 0; V <sub>GS</sub> = -10 V; f = 1 MHz	15	30	pF
		V <sub>DS</sub> = 0; V <sub>GS</sub> = 0; f = 1 MHz; T <sub>amb</sub> = 25 °C	50	85	pF
C <sub>rs</sub>	reverse transfer capacitance	V <sub>DS</sub> = 0; V <sub>GS</sub> = -10 V; f = 1 MHz	8	15	pF
Switching times; see Fig.2					
t <sub>d</sub>	delay time	note 1	2	—	ns
t <sub>on</sub>	turn-on time		4	—	ns
t <sub>s</sub>	storage time		4	—	ns
t <sub>off</sub>	turn-off time		6	—	ns

Note

1. Test conditions for switching times are as follows:
- V<sub>DD</sub> = 1.5 V; V<sub>GS</sub> = 0 to V<sub>GSoff</sub> (all types)
- V<sub>GSoff</sub> = -12 V; R<sub>L</sub> = 100 Ω (J108)
- V<sub>GSoff</sub> = -7 V; R<sub>L</sub> = 100 Ω (J109)
- V<sub>GSoff</sub> = -5 V; R<sub>L</sub> = 100 Ω (J110).



[查询"1108AMC"供应商](#)  
n-channel silicon junction FETs

J108; J109; J110

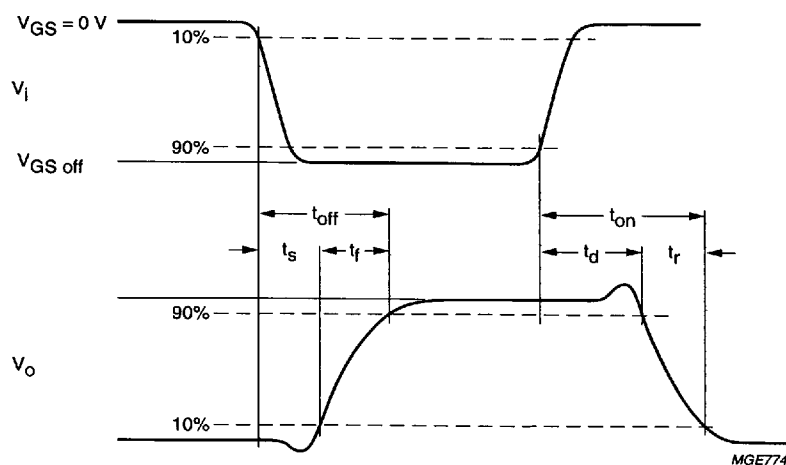


Fig.3 Input and output waveforms.

[查询"J108AMQ"供应商](#)  
N-channel silicon junction FETs

J108; J109; J110

## PACKAGE OUTLINE

